

Search Notes

Application/Control No.

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Examiner

Chau N. Nguyen

Applicant(s)/Patent under
Reexamination

WIEKHORST, DAVID

Art Unit

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SEARCHED

Class	Subclass	Date	Examiner
174	110R	12/20/2007	CN
	113R		

INTERFERENCE SEARCHED

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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR